

CoolSiC[™] SiC Schottky Diode

Features:

- Revolutionary semiconductor material Silicon Carbide
- No reverse recovery current / No forward recovery
- Temperature independent switching behavior
- Low forward voltage even at high operating temperature
- Tight forward voltage distribution
- Excellent thermal performance
- Extended surge current capability
- Specified dv/dt ruggedness
- Qualified according to JEDEC¹⁾ for target applications
- Pb-free lead plating; RoHS compliant

Benefits

- System efficiency improvement over Si diodes
- Enabling higher frequency / increased power density solutions
- System size / cost savings due to reduced heatsink requirements and smaller magnetics
- Reduced EMI
- Highest efficiency across the entire load range
- Robust diode operation during surge events
- High reliability
- RelatedLinks: <u>www.infineon.com/sic</u>

Applications

- Solar inverters
- Uninterruptable power supplies
- Motor drives
- Power Factor Correction

Package pin definitions

- Pin 1 and backside cathode
- Pin 2 anode



Key Performance and Package Parameters

| Туре | V _{DC} | I _F | Q _C | T _{j,max} | Marking | Package |
|-------------|-----------------|----------------|----------------|---------------------------|---------|--------------|
| IDH02G120C5 | 1200V | 2A | 14nC | 175°C | D0212C5 | PG-TO220-2-1 |

1) J-STD20 and JESD22

Final Data Sheet

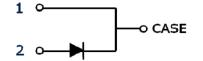




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Maximum ratings

| Parameter | Symbol | Value | Unit | |
|---|----------------------------------|------------------|------|--|
| Repetitive peak reverse voltage | Vrrm | 1200 | V | |
| Continues forward current for $R_{th(j-c,max)}$ $T_c = 168^{\circ}C, D=1$ $T_c = 135^{\circ}C, D=1$ $T_c = 25^{\circ}C, D=1$ | IF | 2 5.7 11.8 | A | |
| Surge non-repetitive forward current, sine halfwave $T_{\rm C}$ =25°C, t _p =10ms $T_{\rm C}$ =150°C, t _p =10ms | <i>I</i> f,sm | 37 31 | A | |
| Non-repetitive peak forward current $T_{\rm C} = 25^{\circ}{\rm C}, t_{\rm P} = 10 \ \mu{\rm s}$ | I _{F,max} | 344 | А | |
| i ² t value $T_{\rm C}$ = 25°C, $t_{\rm p}$ =10 ms $T_{\rm C}$ = 150°C, $t_{\rm p}$ =10 ms | ∫ i²dt | 7 4.9 | A²s | |
| Diode dv/dt ruggedness V _R =0960V | dv/dt | 150 | V/ns | |
| Power dissipation $T_{\rm C} = 25^{\circ}{\rm C}$ | Ptot | 75 | W | |
| Operating and storage temperature | T _j ;T _{stg} | -55175 | °C | |
| Soldering temperature, wavesoldering only allowed at leads, 1.6mm (0.063 in.) from case for 10 s | T _{sold} | 260 | °C | |
| Mounting torque M3 and M4 screws | М | 0.7 | Nm | |

Thermal Resistances

| Parameter | Symbol | Conditions | | Value | Unit | |
|---|----------------------|------------|------|-------|------|------|
| Falameter | Symbol | Conditions | min. | typ. | max. | Unit |
| Characteristic | | | | | | |
| Diode thermal resistance, junction – case | R _{th(j-c)} | | - | 1.54 | 2 | K/W |
| Thermal resistance, junction – ambient | Rth(j-a) | leaded | - | - | 62 | K/W |



Electrical Characterics

Static Characteristics, at T_j=25°C, unless otherwise specified

| Parameter | Symbol | Conditions min. | | Value | Unit | |
|-----------------------|-----------------|--|------|-------|------|------|
| Farameter | Symbol | | min. | typ. | max. | Onit |
| Static Characteristic | | | | | | |
| DC blocking voltage | V _{DC} | $T_{\rm j} = 25^{\circ}{\rm C}$ | 1200 | - | - | V |
| Diode forward voltage | VF | <i>I</i> ⊧= 2A, <i>T</i> j=25°C | - | 1.4 | 1.65 | V |
| Didde forward voltage | | <i>I</i> ⊧= 2A, <i>T</i> ј=150°C | - | 1.7 | 2.3 | |
| Reverse current | I _R | <i>V</i> _R =1200V, <i>T</i> _j =25°C | | 1.2 | 18 | μA |
| | | <i>V</i> _R =1200V, <i>T</i> _j =150°C | | 6 | 90 | |

Dynamic Characteristics, at Tj=25°C, unless otherwise specified

| Parameter | Symbol | Conditions | Value | | | Unit |
|-------------------------|--------|--|-------------|-----------------|------|------|
| Falameter | | | min. | typ. | max. | Onit |
| Dynamic Characteristics | | | | | | |
| Total capacitive charge | Qc | $V_{\rm R}=800 \text{V}, \ T_{\rm j}=150^{\circ}\text{C}$ $Q_C = \int_0^{V_R} C(V) dV$ | - | 14 | - | nC |
| Total Capacitance | с | V _R =1 V, <i>f</i> =1 MHz V _R =400 V, <i>f</i> =1 MHz V _R =800 V, <i>f</i> =1 MHz | - - - | 182 13 10 | - | pF |



IDH02G120C5

5th Generation CoolSiC[™] 1200 V SiC Schottky Diode

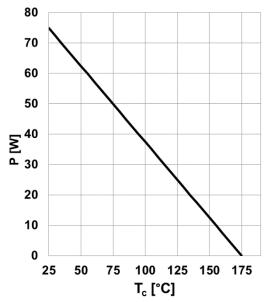


Figure 1. Power dissipation as a function of case temperature, $P_{tot}=f(T_C)$, $R_{th(j-c),max}$

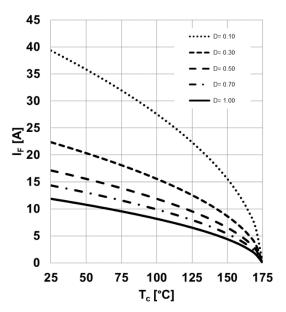
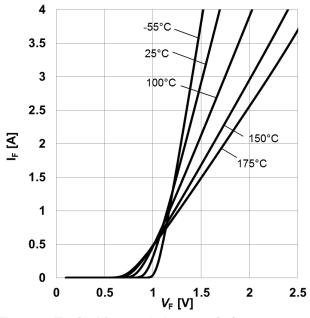
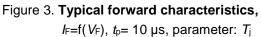


Figure 2. Diode forward current as function of temperature, $T_j \le 175^{\circ}$ C, $R_{th(j-c),max}$, parameter D=duty cycle, V_{th} , R_{diff} @ T_j =175°C





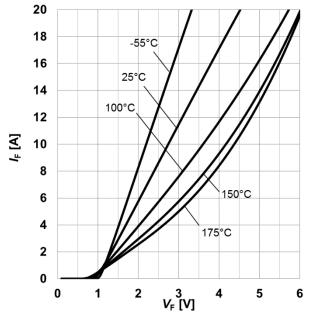


Figure 4. Typical forward characteristics in surge current, $I_F=f(V_F)$, $t_p=10 \ \mu s$, parameter: T_j



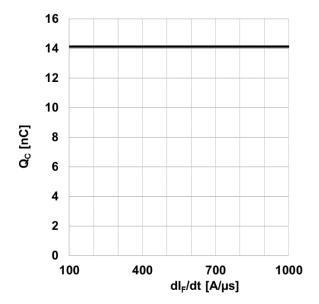


Figure 5. **Typical capacitive charge as function** of current slope¹, Q_C=f(*dl*=/*dt*), *T*_j=150°C 1) Only capacitive charge, guaranteed by design.

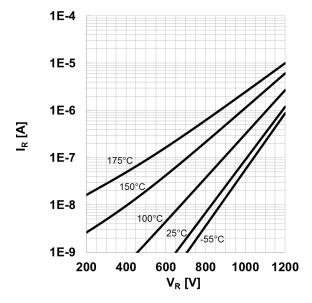
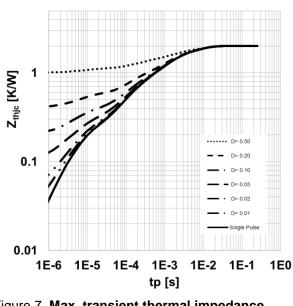
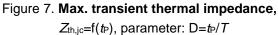


Figure 6. Typical reverse current as function of reverse voltage, $I_R=f(V_R)$, parameter: T_j





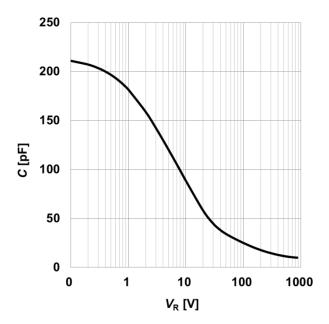


Figure 8. **Typical capacitance as function of** reverse voltage, *C*=f(*V*_R); *T*_j=25°C; *f*=1 MHz



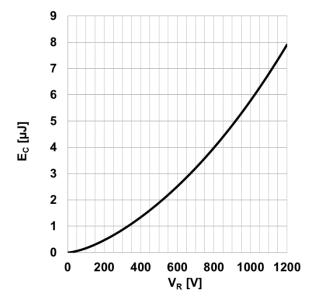


Figure 9. Typical capacitively stored energy as function of reverse voltage,

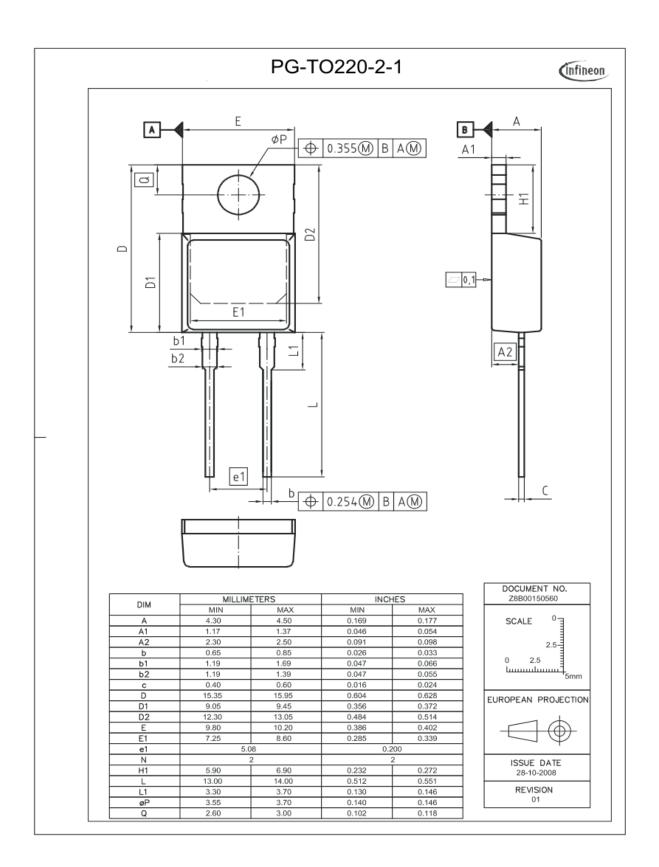
$$E_C = \int_0^{V_R} C(V) V dV$$

Final Data Sheet



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Final Data Sheet



Revision History

IDH02G120C5

Revision:2021-03-01, Rev. 2.2

| Previous Revision: | | | | | | |
|--------------------|------------|---|--|--|--|--|
| Revision | Date | Subjects (major changes since last version) | | | | |
| 2.0 | 2015-07-22 | Final data sheet | | | | |
| 2.1 | 2017-07-21 | Editorial change | | | | |
| 2.2 | 2021-03-01 | Increased dv/dt ruggedness | | | | |

We Listen to Your Comments

Any information within this document that you feel is wrong, unclear or missing at all? Your feedback will help us to continuously improve the quality of this document. Please send your proposal (including a reference to this document) to: erratum@infineon.com



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